

**Search Notes**

Application/Control No.

10/668,234

Examiner

Leonardo Andújar

Applicant(s)/Patent under  
Reexamination

SEKO, TOSHIHARU

Art Unit

2826

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
257/ 778, 786 782,783 text search see search notes	2/27/2006	LA